





RADIO TEST REPORT

Test Report No. 14991479H-A-R1

Customer	DENSO CORPORATION
Description of EUT	Electronic Key
Model Number of EUT	14FLE
FCC ID	HYQ14FLE
Test Regulation	FCC Part 15 Subpart C
Test Result	Complied
Issue Date	November 6, 2023
Remarks	-

Representative test engineer	Approved by
	
Tomoya Sone Engineer	Shinichi Miyazono Engineer
	 
	CERTIFICATE 5107.02
<input type="checkbox"/> The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan, Inc.	
<input checked="" type="checkbox"/> There is no testing item of "Non-accreditation".	

Report Cover Page - Form-ULID-003532 (DCS:13-EM-F0429) Issue# 23.0

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- The information provided from the customer for this report is identified in SECTION 1.
- For test report(s) referred in this report, the latest version (including any revisions) is always referred.

REVISION HISTORY

Original Test Report No. 14991479H-A

This report is a revised version of 14991479H-A. 14991479H-A is replaced with this report.

Revision	Test Report No.	Date	Page Revised Contents
- (Original)	14991479H-A	October 24, 2023	-
1	14991479H-A-R1	November 6, 2023	Correction of erroneous description for page 6
1	14991479H-A-R1	November 6, 2023	Partial correction of Uncertainty table in Section 3.4
1	14991479H-A-R1	November 6, 2023	Correction of erroneous description for page 12 SVSWR Volume: 1.5 m to SVSWR Volume: 2.0 m

Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	ICES	Interference-Causing Equipment Standard
AC	Alternating Current	IEC	International Electrotechnical Commission
AFH	Adaptive Frequency Hopping	IEEE	Institute of Electrical and Electronics Engineers
AM	Amplitude Modulation	IF	Intermediate Frequency
Amp, AMP	Amplifier	ILAC	International Laboratory Accreditation Conference
ANSI	American National Standards Institute	ISED	Innovation, Science and Economic Development Canada
Ant, ANT	Antenna	ISO	International Organization for Standardization
AP	Access Point	JAB	Japan Accreditation Board
ASK	Amplitude Shift Keying	LAN	Local Area Network
Atten., ATT	Attenuator	LIMS	Laboratory Information Management System
AV	Average	MCS	Modulation and Coding Scheme
BPSK	Binary Phase-Shift Keying	MRA	Mutual Recognition Arrangement
BR	Bluetooth Basic Rate	N/A	Not Applicable
BT	Bluetooth	NIST	National Institute of Standards and Technology
BT LE	Bluetooth Low Energy	NS	No signal detect.
BW	BandWidth	NSA	Normalized Site Attenuation
Cal Int	Calibration Interval	NVLAP	National Voluntary Laboratory Accreditation Program
CCK	Complementary Code Keying	OBW	Occupied Band Width
Ch., CH	Channel	OFDM	Orthogonal Frequency Division Multiplexing
CISPR	Comite International Special des Perturbations Radioelectriques	P/M	Power meter
CW	Continuous Wave	PCB	Printed Circuit Board
DBPSK	Differential BPSK	PER	Packet Error Rate
DC	Direct Current	PHY	Physical Layer
D-factor	Distance factor	PK	Peak
DFS	Dynamic Frequency Selection	PN	Pseudo random Noise
DQPSK	Differential QPSK	PRBS	Pseudo-Random Bit Sequence
DSSS	Direct Sequence Spread Spectrum	PSD	Power Spectral Density
EDR	Enhanced Data Rate	QAM	Quadrature Amplitude Modulation
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	QP	Quasi-Peak
EMC	ElectroMagnetic Compatibility	QPSK	Quadri-Phase Shift Keying
EMI	ElectroMagnetic Interference	RBW	Resolution Band Width
EN	European Norm	RDS	Radio Data System
ERP, e.r.p.	Effective Radiated Power	RE	Radio Equipment
EU	European Union	RF	Radio Frequency
EUT	Equipment Under Test	RMS	Root Mean Square
Fac.	Factor	RSS	Radio Standards Specifications
FCC	Federal Communications Commission	Rx	Receiving
FHSS	Frequency Hopping Spread Spectrum	SA, S/A	Spectrum Analyzer
FM	Frequency Modulation	SG	Signal Generator
Freq.	Frequency	SVSWR	Site-Voltage Standing Wave Ratio
FSK	Frequency Shift Keying	TR	Test Receiver
GFSK	Gaussian Frequency-Shift Keying	Tx	Transmitting
GNSS	Global Navigation Satellite System	VBW	Video BandWidth
GPS	Global Positioning System	Vert.	Vertical
Hori.	Horizontal	WLAN	Wireless LAN

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SECTION 1: Customer Information

Company Name	DENSO CORPORATION
Address	1-1, Showa-cho, Kariya-shi, Aichi-ken, 448-8661, Japan
Telephone Number	+81-50-3171-5999
Contact Person	TSUYOSHI YAMAMOTO

The information provided from the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing

* The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment Under Test (EUT)

2.1 Identification of EUT

Description	Electronic Key
Model Number	14FLE
Serial Number	Refer to SECTION 4.2
Condition	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification	No Modification by the test lab
Receipt Date	October 8, 2023
Test Date	October 13 and 15, 2023

2.2 Product Description

General Specification

Rating	DC 3.0 V
--------	----------

Radio Specification

Equipment Type	Transmitter
Frequency of Operation	312.10 MHz / 314.35 MHz* *These two different frequencies are not emitted simultaneously.
Type of Modulation	FSK (F1D)
Type of Battery	One lithium battery
Antenna type	Built-in type (Fixed)

Equipment Type	Receiver
Frequency of Operation	125 kHz

* Original model: 14FLE has the following four types;

Type A	Pattern A
	Pattern B
Type B	Pattern A
	Pattern B

The worst case was confirmed with Type A and Type B at pre check.
The test was performed with Type A as representative since there is no difference the worst result between those models.

The worst case was confirmed with Pattern A and Pattern B at pre check.
The test was performed with Pattern A as representative since there is no difference the worst result between those models.

** Original model No.: 14FLE has 4 switches.
Variation model have 2 switches and 3 switches.
The differences of original model and variation models are only the number of switch and design.
They are completely identical in RF performance.
Therefore the test was performed with the representative original type which was the worst one.

SECTION 3: Test Specification, Procedures & Results

3.1 Test Specification

Test Specification	FCC Part 15 Subpart C The latest version on the first day of the testing period
Title	FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators Section 15.231 Periodic operation in the band 40.66-40.70 MHz and above 70 MHz.

3.2 Procedures and Results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.10:2013 6 Standard test methods ISED: RSS-Gen 8.8	FCC: Section 15.207 ISED: RSS-Gen 8.8	N/A	N/A	*1)
Automatically Deactivate	FCC: ANSI C63.10:2013 6 Standard test methods ISED: -	FCC: Section 15.231(a)(1) ISED: RSS-210 A1.1	N/A	Complied	Radiated
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.10:2013 6 Standard test methods ISED: RSS-Gen 6.12	FCC: Section 15.231(b) ISED: RSS-210 A1.2	4.1 dB 312.100 MHz Horizontal, PK with Duty Factor (Mode 2)	Complied	Radiated
Electric Field Strength of Spurious Emission	FCC: ANSI C63.10:2013 6 Standard test methods ISED: RSS-Gen 6.13	FCC: Section 15.205 Section 15.209 Section 15.231(b) ISED: RSS-210 A1.2 RSS-Gen 8.9	12.6 dB 936.300 MHz Horizontal, PK with Duty Factor (Mode 2)	Complied	Radiated
-20 dB Bandwidth	FCC: ANSI C63.10:2013 6 Standard test methods ISED: -	FCC: Section 15.231(c) ISED: Reference data	N/A	Complied	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593.

*1) The test is not applicable since the EUT does not have AC Mains.

FCC Part 15.31 (e)

The test was performed with the New Battery during the tests.
Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT.
Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to Standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% emission bandwidth	ANSI C63.10:2013 6 Standard test methods	Reference data	N/A	-	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593.

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

Measurement uncertainty is not taken into account when stating conformity with a specified requirement. Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Radiated emission

Measurement distance	Frequency Range		Unit	Calculated Uncertainty (+/-)
3 m	9 kHz to 30 MHz		dB	3.3
10 m			dB	3.1
3 m	30 MHz to 200 MHz	Horizontal	dB	4.8
		Vertical	dB	5.0
	200 MHz to 1000 MHz	Horizontal	dB	5.1
		Vertical	dB	6.2
10 m	30 MHz to 200 MHz	Horizontal	dB	4.8
		Vertical	dB	4.8
	200 MHz to 1000 MHz	Horizontal	dB	4.9
		Vertical	dB	5.0
3 m	1 GHz to 6 GHz		dB	4.9
	6 GHz to 18 GHz		dB	5.2
1 m	10 GHz to 26.5 GHz		dB	5.5
	26.5 GHz to 40 GHz		dB	5.4

Automatically Deactivate, -20 dB Bandwidth and 99% emission bandwidth

Item	Unit	Calculated Uncertainty (+/-)
Bandwidth (OBW)	%	0.96
Time Readout (Time span upto 100 msec)	%	0.11
Time Readout (Time span upto 1000 msec)	%	0.11
Time Readout (Time span upto 60 sec)	%	0.02

3.5 Test Location

UL Japan, Inc. Ise EMC Lab.
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 Japan
Telephone: +81-596-24-8999

*A2LA Certificate Number: 5107.02 / FCC Test Firm Registration Number: 884919

ISED Lab Company Number: 2973C / CAB identifier: JP0002

Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.10 shielded room	3.8 x 2.8 x 2.8	3.8 x 2.8	-	-
No.11 measurement room	4.0 x 3.4 x 2.5	N/A	-	-
No.12 measurement room	2.6 x 3.4 x 2.5	N/A	-	-
Large Chamber	16.9 x 22.1 x 10.17	16.9 x 22.1	-	10 m
Small Chamber	5.3 x 6.69 x 3.59	5.3 x 6.69	-	-

3.6 Test Data, Test Instruments, and Test Set Up

Refer to APPENDIX.

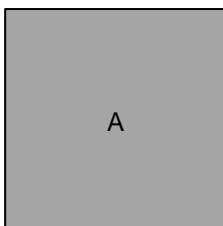
SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

Test mode	Remarks
1) Normal use mode (312.10 MHz / 314.35 MHz)	-
2) Transmitting mode (312.10 MHz)	-
3) Transmitting mode (314.35 MHz)	-
* The system was configured in typical fashion (as a user would normally use it) for testing.	
*Power of the EUT was set by the software as follows; Software: Product program Version: 80015000 (Date: 2022.12 26, Storage location: EUT memory)	
*This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.	
Justification: The system was configured in typical fashion (as a user would normally use it) for testing.	

This EUT has two modes which mechanical key is inserted or not. The worst case was confirmed with and without mechanical key inserted, as a result, the test without mechanical key inserted was the worst case. Therefore, the test without mechanical key inserted was performed only.

4.2 Configuration and Peripherals



* Setup was taken into consideration and test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial Number	Manufacturer	Remark
A	Electronic Key	14FLE	No.1 *1) No.2 *2)	DENSO CORPORATION	EUT

*1) Used for Automatically Deactivate test

*2) Used for other tests except for Automatically Deactivate test

SECTION 5: Radiated Spurious Emission

Test Procedure

[For below 30 MHz]

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

[For 30 MHz to 1 GHz]

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The measurements were performed for both vertical and horizontal antenna polarization.

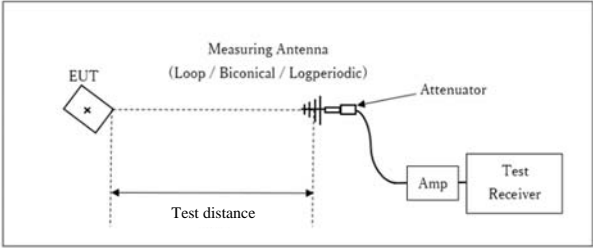
The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

Frequency	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz	Above 1 GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200 Hz	200 Hz	9.1 kHz	9.1 kHz	120 kHz	PK: S/A: RBW: 1 MHz, VBW: 3 MHz

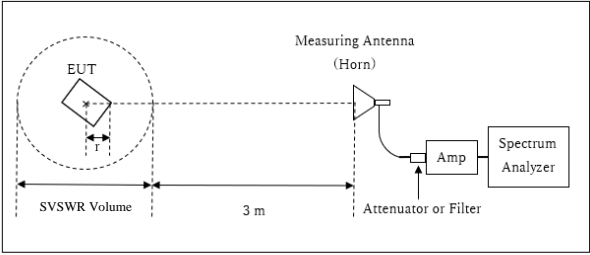
[Test Setup]
 Below 1 GHz



Test Distance: 3 m

× : Center of turn table

1 GHz to 3.2 GHz



Distance Factor: $20 \times \log(4.0 \text{ m} / 3.0 \text{ m}) = 2.50 \text{ dB}$
 * Test Distance: $(3 + \text{SVSWR Volume} / 2) - r = 4.0 \text{ m}$

SVSWR Volume : 2.0 m
 (SVSWR Volume has been calibrated based on CISPR 16-1-4.)
 $r = 0.0 \text{ m}$

r : Radius of an outer periphery of EUT
 × : Center of turn table

* The test was performed with $r = 0.0 \text{ m}$ since EUT is small and it was the rather conservative condition.

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 9 kHz to 3.2 GHz
Test data : APPENDIX
Test result : Pass

SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX
Test result : Pass

SECTION 7: -20 dB Bandwidth and 99% emission bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
-20 dB Bandwidth / 99% emission bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer

*1) Peak hold was applied as Worst-case measurement.

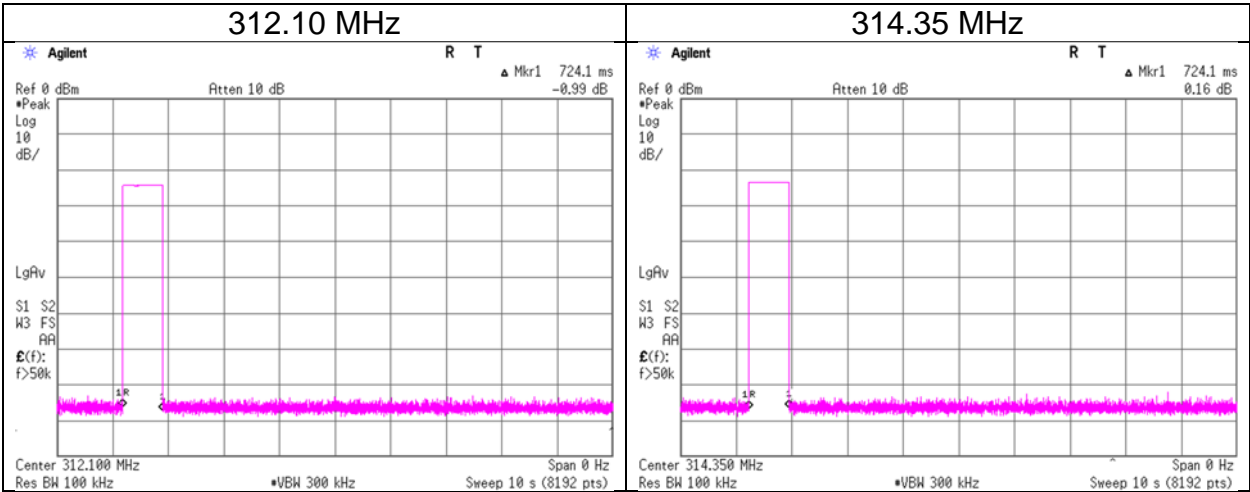
Test data : APPENDIX
Test result : Pass

APPENDIX 1: Test Data

Automatically deactivate

Test place	Ise EMC Lab.
Measurement Room	No.6
Date	October 13, 2023
Temperature / Humidity	23 deg. C / 36 % RH
Engineer	Sayaka Hara
Mode	Mode 1

Frequency [MHz]	Time of Transmitting [s]	Limit [s]	Result
312.10	0.7241	5.00	Pass
314.35	0.7241	5.00	Pass



* The EUT transmits UHF when LF signal is received from a car or a button on the EUT is pressed. In both cases, the UHF transmission is stopped within 5 seconds. So the test was performed by a button-pressed operation as the worst case.

Radiated Emission (Fundamental and Spurious Emission)

Test place	Ise EMC Lab.	No.3
Semi Anechoic Chamber	No.2	October 15, 2023
Date	October 13, 2023	22 deg. C / 51 % RH
Temperature / Humidity	23 deg. C / 42 % RH	Hiroyuki Furutaka
Engineer	Tomoya Sone	(Above 1 GHz)
	(Below 1 GHz)	
Mode	Mode 2	

Polarity [Hori/Vert]	Frequency [MHz]	Reading (PK) [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (PK) [dBuV/m]	Result (PK with Duty Factor) [dBuV/m]	Limit (PK) [dBuV/m]	Limit (AV) [dBuV/m]	Margin (PK) [dB]	Margin (AV) [dB]	Inside or Outside of Restricted Bands	Remarks
Hori.	312.100	76.2	14.1	8.8	27.8	0.0	71.3	71.3	95.4	75.4	24.1	4.1	Carrier	
Hori.	624.200	36.6	19.5	10.2	29.3	0.0	37.0	37.0	75.4	55.4	38.4	18.4	Outside	
Hori.	936.300	38.2	22.0	11.4	28.8	0.0	42.8	42.8	75.4	55.4	32.6	12.6	Outside	
Hori.	1248.400	44.0	25.5	6.0	34.4	-	41.1	41.1	75.4	55.4	34.3	14.3	Outside	Floor noise
Hori.	1560.500	42.8	25.3	5.2	33.7	-	39.6	39.6	73.9	53.9	34.3	14.3	Inside	Floor noise
Hori.	1872.600	42.1	25.4	5.2	32.9	-	39.8	39.8	75.4	55.4	35.6	15.6	Outside	Floor noise
Hori.	2184.700	42.6	28.2	5.3	32.5	-	43.6	43.6	75.4	55.4	31.8	11.8	Outside	Floor noise
Hori.	2496.800	42.2	27.5	5.3	32.4	-	42.6	42.6	73.9	53.9	31.3	11.3	Inside	Floor noise
Hori.	2808.900	41.9	28.5	5.5	32.2	-	43.7	43.7	73.9	53.9	30.2	10.2	Inside	Floor noise
Hori.	3121.000	39.6	28.8	5.8	32.1	-	42.1	42.1	75.4	55.4	33.3	13.3	Outside	Floor noise
Vert.	312.100	73.5	14.1	8.8	27.8	0.0	68.6	68.6	95.4	75.4	26.8	6.8	Carrier	
Vert.	624.200	34.7	19.5	10.2	29.3	0.0	35.1	35.1	75.4	55.4	40.3	20.3	Outside	
Vert.	936.300	36.8	22.0	11.4	28.8	0.0	41.4	41.4	75.4	55.4	34.0	14.0	Outside	
Vert.	1248.400	44.1	25.5	6.0	34.4	-	41.2	41.2	75.4	55.4	34.2	14.2	Outside	Floor noise
Vert.	1560.500	42.9	25.3	5.2	33.7	-	39.7	39.7	73.9	53.9	34.2	14.2	Inside	Floor noise
Vert.	1872.600	42.3	25.4	5.2	32.9	-	40.0	40.0	75.4	55.4	35.4	15.4	Outside	Floor noise
Vert.	2184.700	42.8	28.2	5.3	32.5	-	43.8	43.8	75.4	55.4	31.6	11.6	Outside	Floor noise
Vert.	2496.800	42.4	27.5	5.3	32.4	-	42.8	42.8	73.9	53.9	31.1	11.1	Inside	Floor noise
Vert.	2808.900	42.0	28.5	5.5	32.2	-	43.8	43.8	73.9	53.9	30.1	10.1	Inside	Floor noise
Vert.	3121.000	39.9	28.8	5.8	32.1	-	42.4	42.4	75.4	55.4	33.0	13.0	Outside	Floor noise

Sample calculation:

Result of PK = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) + Distance factor (above 1 GHz)} - Gain (Amplifier)

Result of PK with Duty factor (PK / W) = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) + Distance factor (above 1 GHz)} - Gain (Amplifier) + Duty factor

For above 1 GHz: Distance Factor: $20 \times \log(4.0 \text{ m}/3.0 \text{ m}) = 2.50 \text{ dB}$

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Since the peak emission result satisfied the average limit, duty factor was omitted.

Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100 % as worst.

If Gain 0.0 dB shown in the above table, pre-amplifier was not used to avoid the influence of carrier power. The pre-amplifier used for carrier frequency measurement was not saturated.

Radiated Emission (Fundamental and Spurious Emission)

Test place	Ise EMC Lab.	No.3
Semi Anechoic Chamber	No.2	October 15, 2023
Date	October 13, 2023	22 deg. C / 51 % RH
Temperature / Humidity	23 deg. C / 42 % RH	Hiroyuki Furutaka
Engineer	Tomoya Sone	(Above 1 GHz)
	(Below 1 GHz)	
Mode	Mode 3	

Polarity [Hori/Vert]	Frequency [MHz]	Reading (PK) [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (PK) [dBuV/m]	Result (PK with Duty Factor) [dBuV/m]	Limit (PK) [dBuV/m]	Limit (AV) [dBuV/m]	Margin (PK) [dB]	Margin (AV) [dB]	Inside or Outside of Restricted Bands	Remarks
Hori.	314.350	76.1	14.2	8.8	27.8	0.0	71.3	71.3	95.5	75.5	24.2	4.2	Carrier	
Hori.	628.700	36.7	19.5	10.2	29.3	0.0	37.1	37.1	75.5	55.5	38.4	18.4	Outside	
Hori.	943.050	35.6	22.1	11.4	28.7	0.0	40.4	40.4	75.5	55.5	35.1	15.1	Outside	
Hori.	1257.400	43.3	25.6	5.9	34.4	-	40.4	40.4	75.5	55.5	35.1	15.1	Outside	Floor noise
Hori.	1571.750	42.1	25.2	5.2	33.6	-	38.9	38.9	73.9	53.9	35.0	15.0	Inside	Floor noise
Hori.	1886.100	41.9	25.5	5.2	32.9	-	39.7	39.7	75.5	55.5	35.8	15.8	Outside	Floor noise
Hori.	2200.450	41.6	28.3	5.3	32.5	-	42.7	42.7	73.9	53.9	31.2	11.2	Inside	Floor noise
Hori.	2514.800	41.8	27.6	5.3	32.4	-	42.3	42.3	75.5	55.5	33.2	13.2	Outside	Floor noise
Hori.	2829.150	41.5	28.6	5.5	32.2	-	43.4	43.4	73.9	53.9	30.5	10.5	Inside	Floor noise
Hori.	3143.500	39.6	28.8	5.8	32.1	-	42.1	42.1	75.5	55.5	33.4	13.4	Outside	Floor noise
Vert.	314.350	73.1	14.2	8.8	27.8	0.0	68.3	68.3	95.5	75.5	27.2	7.2	Carrier	
Vert.	628.700	33.6	19.5	10.2	29.3	0.0	34.0	34.0	75.5	55.5	41.5	21.5	Outside	
Vert.	943.050	34.1	22.1	11.4	28.7	0.0	38.9	38.9	75.5	55.5	36.6	16.6	Outside	
Vert.	1257.400	43.4	25.6	5.9	34.4	-	40.5	40.5	75.5	55.5	35.0	15.0	Outside	Floor noise
Vert.	1571.750	42.3	25.2	5.2	33.6	-	39.1	39.1	73.9	53.9	34.8	14.8	Inside	Floor noise
Vert.	1886.100	42.0	25.5	5.2	32.9	-	39.8	39.8	75.5	55.5	35.7	15.7	Outside	Floor noise
Vert.	2200.450	41.7	28.3	5.3	32.5	-	42.8	42.8	73.9	53.9	31.1	11.1	Inside	Floor noise
Vert.	2514.800	41.9	27.6	5.3	32.4	-	42.4	42.4	75.5	55.5	33.1	13.1	Outside	Floor noise
Vert.	2829.150	41.7	28.6	5.5	32.2	-	43.6	43.6	73.9	53.9	30.3	10.3	Inside	Floor noise
Vert.	3143.500	39.8	28.8	5.8	32.1	-	42.3	42.3	75.5	55.5	33.2	13.2	Outside	Floor noise

Sample calculation:

Result of PK = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) +Distance factor (above 1 GHz)} - Gain (Amplifier)

Result of PK with Duty factor (PK / W) = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) +Distance factor (above 1 GHz)} - Gain (Amplifier) + Duty factor

For above 1 GHz: Distance Factor: $20 \times \log(4.0 \text{ m}/3.0 \text{ m}) = 2.50 \text{ dB}$

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

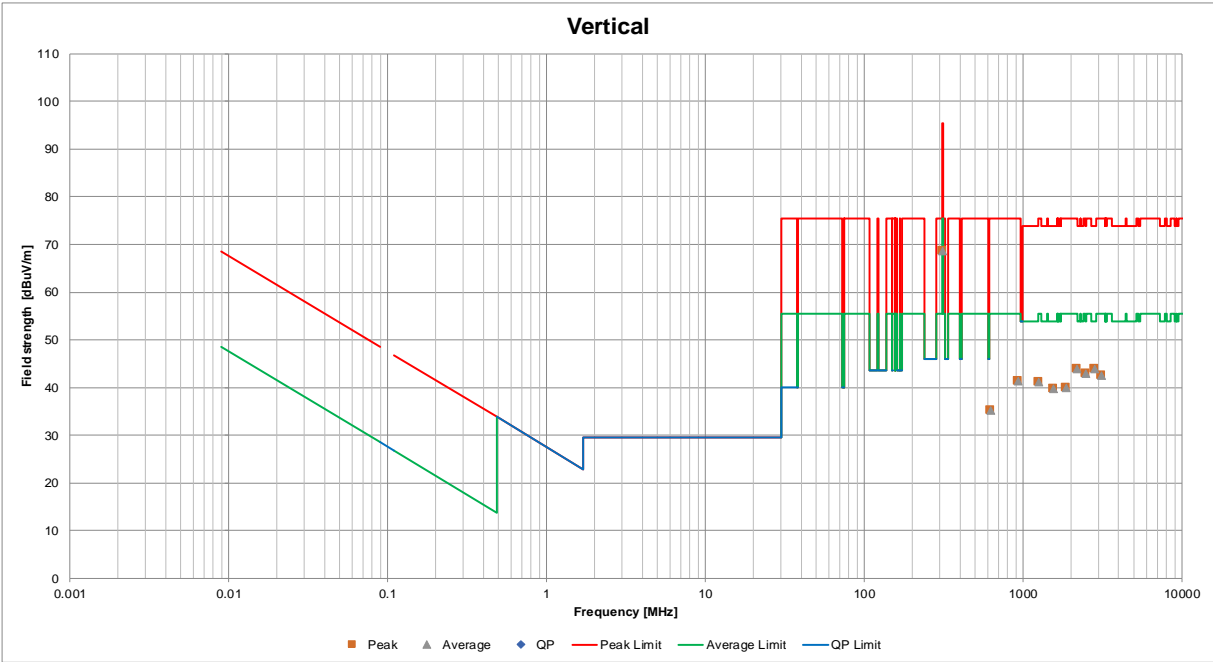
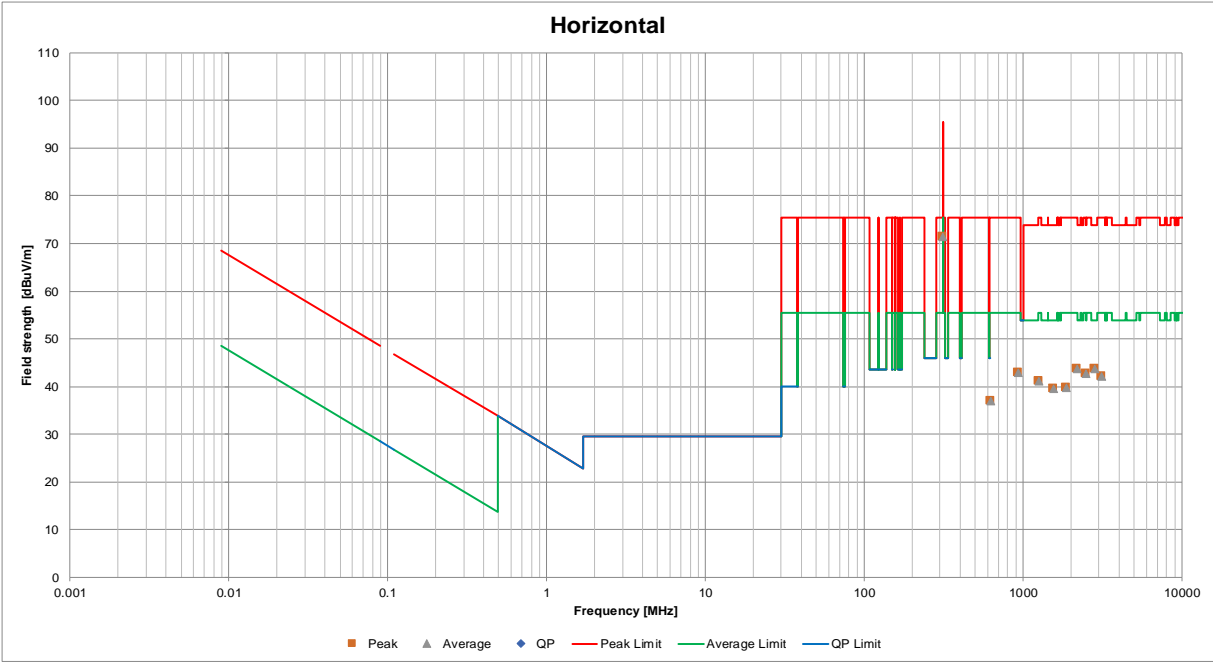
Since the peak emission result satisfied the average limit, duty factor was omitted.

Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100 % as worst.

If Gain 0.0 dB shown in the above table, pre-amplifier was not used to avoid the influence of carrier power. The pre-amplifier used for carrier frequency measurement was not saturated.

Radiated Spurious Emission (Plot data, Worst case for Fundamental Emission)

Test place	Ise EMC Lab.	No.3
Semi Anechoic Chamber	No.2	
Date	October 13, 2023	October 15, 2023
Temperature / Humidity	23 deg. C / 42 % RH	22 deg. C / 51 % RH
Engineer	Tomoya Sone (Below 1 GHz)	Hiroyuki Furutaka (Above 1 GHz)
Mode	Mode 2	



-20 dB Bandwidth / 99% emission bandwidth

Test place Ise EMC Lab.
Semi Anechoic Chamber No.2
Date October 13, 2023
Temperature / Humidity 23 deg. C / 42 % RH
Engineer Tomoya Sone
Mode Mode 2, 3

Bandwidth Limit : Fundamental Frequency 312.10 MHz x 0.25 % = 780.250 kHz

* The above limit was calculated from more stringent nominal frequency.

* Method of KDB 926416 for systems employing non sweeping frequencies was referred.

312.10 MHz

-20 dB Bandwidth [kHz]
39.830

314.35 MHz

-20 dB Bandwidth [kHz]
39.785

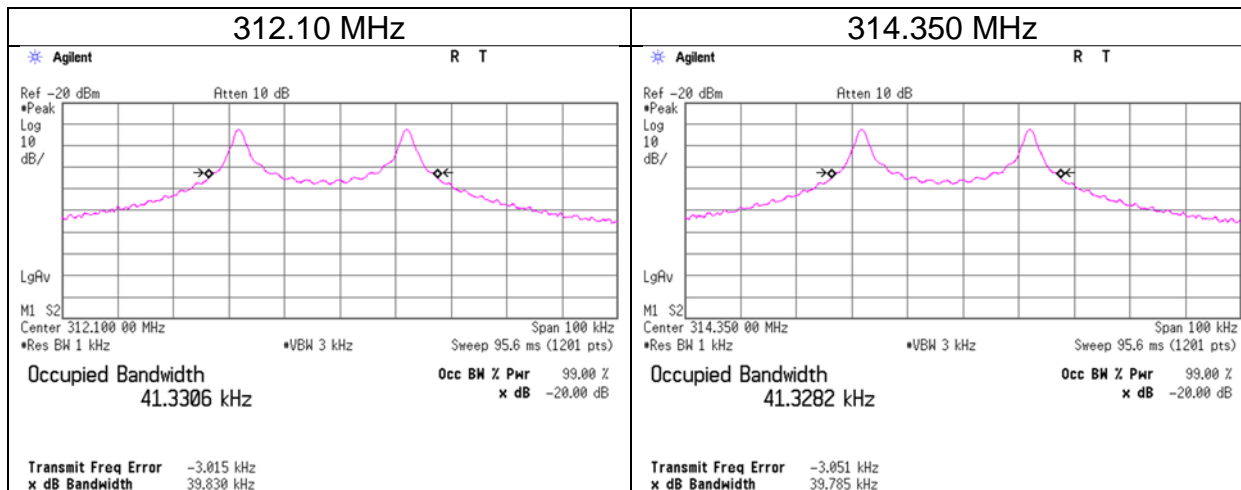
-20 dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
79.615	780.250	Pass

Bandwidth Limit : Fundamental Frequency 312.10 MHz x 0.25 % = 780.250 kHz

99% emission bandwidth [kHz]	Bandwidth Limit [kHz]	Result
41.3306	780.250	Pass

Bandwidth Limit : Fundamental Frequency 314.35 MHz x 0.25 % = 785.875 kHz

99% emission bandwidth [kHz]	Bandwidth Limit [kHz]	Result
41.3282	785.875	Pass



APPENDIX 2: Test Instruments

Test Equipment

Test Item	Local ID	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
RE	COTS-MEMI-02	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	JRENT-02	198469	EMI Test Receiver	Rohde & Schwarz	ESR3	102673	01/05/2023	12
RE	MAEC-02	142004	AC2_Semi Anechoic Chamber (NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	05/30/2022	24
RE	MAEC-03	142008	AC3_Semi Anechoic Chamber (NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	05/23/2022	24
RE	MAEC-03-SVSWR	142013	AC3_Semi Anechoic Chamber (SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	04/12/2023	24
RE	MAT-112	220646	Attenuator	Huber+Suhner	6806_N-50-1	-	03/17/2023	12
RE	MBA-08	141427	Biconical Antenna	Schwarzbeck Mess-Elektronik OHG	VHA9103B+ BBA9106	08031	07/11/2023	12
RE	MCC-12	141317	Coaxial Cable	UL Japan	-	-	09/12/2023	12
RE	MCC-266	240023	Microwave Cable	Huber+Suhner	SF126E/11PC35/11PC35/1000MM,5000MM	537060/126E / 537075/126E	09/08/2023	12
RE	MHA-20	141507	Horn Antenna 1-18GHz	Schwarzbeck Mess-Elektronik OHG	BBHA9120D	258	11/14/2022	12
RE	MHF-04	141403	High Pass Filter 1.22-4.60GHz	Mini-Circuits	VHF-1200	10435	08/02/2023	12
RE	MJM-16	142183	Measure	KOMELON	KMC-36	-	10/03/2022	12
RE	MJM-27	142228	Measure, Tape, Steel	KOMELON	KMC-36	-	-	-
RE	MLA-21	141265	Logperiodic Antenna (200-1000MHz)	Schwarzbeck Mess-Elektronik OHG	VUSLP9111B	9111B-190	07/11/2023	12
RE	MLPA-08	202511	Loop Antenna	UL Japan	-	-	-	-
RE	MMM-01	141542	Digital Tester	Fluke Corporation	FLUKE 26-3	78030611	08/01/2023	12
RE	MMM-08	141532	DIGITAL HiTESTER	HIOKI E.E. CORPORATION	3805	51201197	01/17/2023	12
RE	MMM-18	141558	Digital Tester (TRUE RMS MULTIMETER)	Fluke Corporation	115	17930030	05/29/2023	12
RE	MOS-13	141554	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	1301	01/13/2023	12
RE	MOS-14	141561	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	1401	01/13/2023	12
RE	MOS-41	192300	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	0013	12/17/2022	12
RE	MPA-11	141580	MicroWave System Amplifier	Keysight Technologies Inc	83017A	MY39500779	03/08/2023	12
RE	MPA-24	141594	Pre Amplifier	Keysight Technologies Inc	8447D	2944A10150	02/02/2023	12
RE	MRENT-130	141855	Spectrum Analyzer	Keysight Technologies Inc	E4440A	MY46187750	12/01/2022	12
RE	MSA-13	141900	Spectrum Analyzer	Keysight Technologies Inc	E4440A	MY46185823	06/16/2023	12

*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test item:

RE: Radiated Emission